Applicant(s)/Patent Under Application/Control No. Reexamination 10/721,550 MIYASITA ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 John B Nguyen 2819 **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY US-2003/0123567 A1 07-2003 Shigemasa et al. 375/295 Α US-6,496,549 B1 12-2002 Crawford, Richard D. 375/320 В US-С D US-Ε US-F US-US-USн US-1 US-J Κ US-US-L US-М FOREIGN PATENT DOCUMENTS Date MM-YYYY Document Number Country Name Classification Country Code-Number-Kind Code Ν 0 Р Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧ W Х

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